

1. Scope

This specification applies to KNTC0201/10KF3380 of chip NTC thermistors.

2. Shape and Dimensions

- 1) Dimensions: See Fig.2-1 and Table 2-1.
- 2) Recommended PCB pattern for reflow soldering: See Fig.2-2 and Table 2-1.

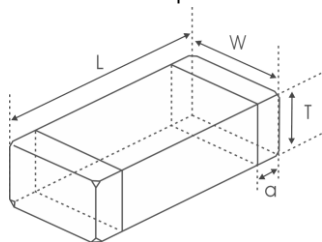


Fig. 2-1

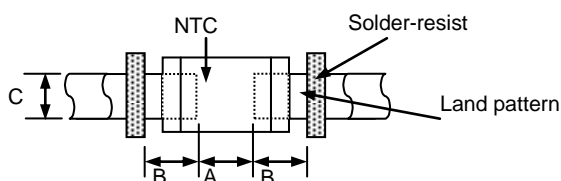


Fig. 2-2

Unit: mm [inch]

[Table 2-1]

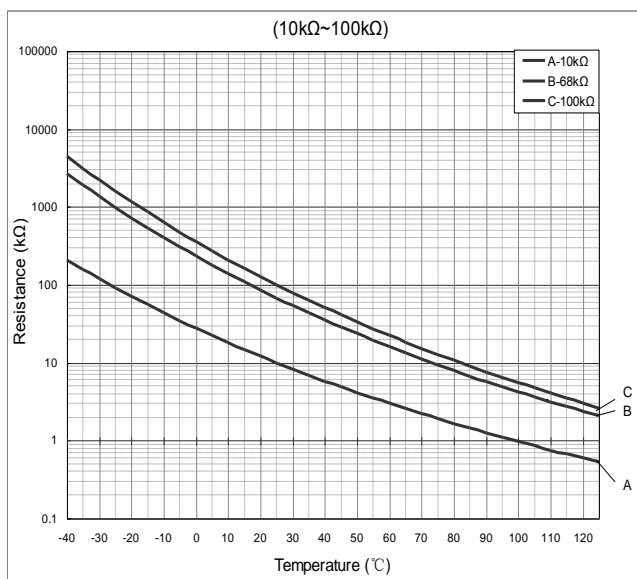
| Type | L | W | T | a | A | B | C |
|----------------|---------------------------|---------------------------|---------------------------|----------------------------|-----------|-----------|-----------|
| 0603 [0201] | 0.6±0.05 [0.024±0.002] | 0.3±0.05 [0.012±0.002] | 0.3±0.05 [0.012±0.002] | 0.15±0.05 [0.006±0.002] | 0.20~0.30 | 0.20~0.30 | 0.30~0.35 |

3. Electrical Characteristics

| Part Number | Resistance at 25°C R25 (kΩ) | B constant (25-50°C) (K) | Max. Permissible Operating Current (25°C) (mA) | Thermal Time Constant | Dissipation Factor (mW/°C) | Rated Electric Power (mW) |
|-------------------|--------------------------------|-----------------------------|---|--------------------------|-------------------------------|------------------------------|
| KNTC0201/10KF3380 | 10 | 3380 | 0.31 | <3sec | 1.0 | 100 |

- 1) Operating and storage temperature range (individual chip without packing): -55°C ~ +125°C
- 2) Storage temperature range (packing conditions): -10°C ~ +40°C and RH 75% (Max.)

TYPICAL ELECTRICAL CHARACTERISTICS



4. Test and Measurement Procedures

4.1 Test Conditions

4.1.1 Unless otherwise specified, the standard atmospheric conditions for measurement/test as:

- a. Ambient Temperature: 20±15°C
- b. Relative Humidity : 65±20%
- c. Air Pressure: 86kPa to 106kPa

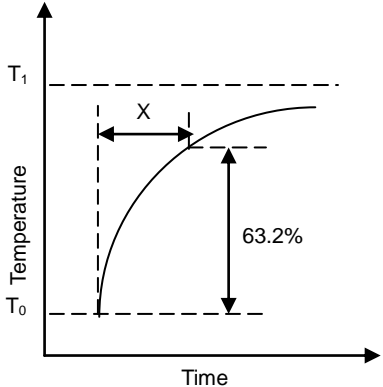
4.1.2 If any doubt on the results, measurements/tests should be made within the following limits:

- a. Ambient Temperature: 20±2°C
- b. Relative Humidity: 65±5%
- c. Air Pressure: 86kPa to 106kPa

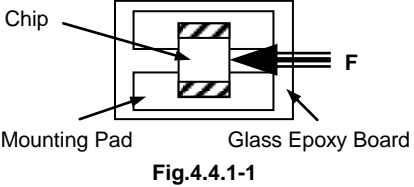
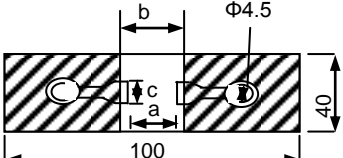
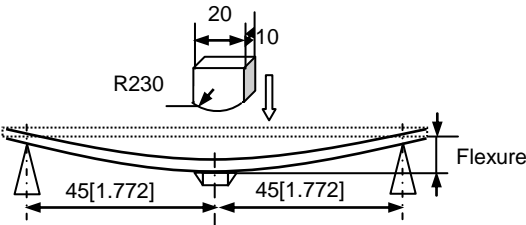
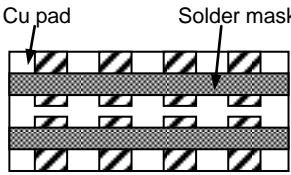
4.2 Visual Examination

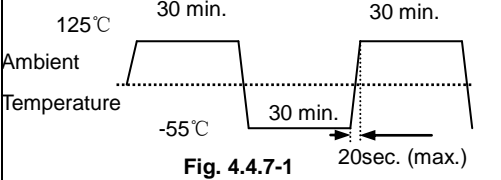
- a. Inspection Equipment: 20× magnifier

4.3 Electrical Test

| Items | Requirements | Test Methods and Remarks |
|--|--|---|
| 4.3.1 Nominal Zero-Power Resistance (R25) | Refer to Item 4 | Ambient temperature: 25±0.2°C. Measuring electric power: 0.1mW Max. |
| 4.3.2 Nominal B Constant | Refer to Item 4 | Measure the resistance at the ambient temperature of 25±0.2°C and 50±0.2°C $B = \frac{\ln R_{25} - \ln R_{50}}{1/T_{25} - 1/T_{50}}$ T: absolute temperature (K) |
| 4.3.3 Thermal Time Constant (single unit) | Refer to Item 4  | The total time for the temperature of the thermistor to change by 63.2% of the difference from ambient temperature T ₀ (°C) to T ₁ (°C) by the drastic change of the power applied to thermistor from Non-zero Power to Zero-Power state. |
| 4.3.4 Dissipation Constant (single unit) | Refer to Item 4 | The total electric power required to raise the temperature of the element by 1°C through self-heating under thermal equilibrium. It calculates by next formula. $C = \frac{W}{T - T_0}$ |
| 4.3.5 Rated Power | Refer to Item 4 | The necessary electric power makes thermistor's temperature rise 100°C by self-heating at ambient temperature 25°C. |
| 4.3.6 Permissive operating current | Refer to Item 4 | The current that keeps body temperature of chip NTC on the PC board in still air rising 1°C by self-heating. |

4.4 Reliability Test

| Items | Requirements | Test Methods and Remarks | | | | | | | | |
|---|---|--|-----|---|---|------------|------|-----|-----|--|
| <p>4.4.1. Terminal Strength</p> | <p>No removal or split of the termination or other defects shall occur.</p>  <p>Fig.4.4.1-1</p> | <ol style="list-style-type: none"> ① Solder the chip to the testing jig (glass epoxy board shown in the following Fig. 4.4.1-1) using eutectic solder. Then apply a force in the direction of the arrow. ② 2N force for 0603 series, ③ Keep time: 10±1s. | | | | | | | | |
| <p>4.4.2 Resistance to Flexure</p> | <p>No visible mechanical damage.</p> <p style="text-align: center;">Unit: mm [inch]</p> <table border="1" data-bbox="308 745 767 831"> <thead> <tr> <th>Type</th> <th>a</th> <th>b</th> <th>c</th> </tr> </thead> <tbody> <tr> <td>0603[0201]</td> <td>0.25</td> <td>0.8</td> <td>0.3</td> </tr> </tbody> </table>  <p>Fig. 4.4.2-1</p> | Type | a | b | c | 0603[0201] | 0.25 | 0.8 | 0.3 | <ol style="list-style-type: none"> ① Solder the chip to the test jig (glass epoxy board shown in Fig. 4.4.2-1) using a eutectic solder. Then apply a force in the direction shown in Fig. 4.4.2-2. ② Flexure: 2mm. ③ Pressurizing Speed: 0.5mm/sec. ④ Keep time: 30 sec.  <p>Fig. 4.4.2-2</p> |
| Type | a | b | c | | | | | | | |
| 0603[0201] | 0.25 | 0.8 | 0.3 | | | | | | | |
| <p>4.4.3 Vibration</p> | <p>No visible mechanical damage.</p>  <p>Fig. 4.4.3-1</p> | <ol style="list-style-type: none"> ① Solder the chip to the testing jig (glass epoxy board shown in Fig. 4.4.3-1) using eutectic solder. ② The chip shall be subjected to a simple harmonic motion having total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55 Hz. ③ The frequency ranging from 10 to 55 Hz and returning to 10 Hz shall be traversed in approximately 1 minute. This motion shall be applied for a period of 2 hours in each 3 mutually perpendicular directions (total of 6 hours). | | | | | | | | |
| <p>4.4.4 Dropping</p> | <ol style="list-style-type: none"> ① No visible mechanical damage. | <p>Drop chip inductor 10 times on a concrete floor from a height of 100 cm.</p> | | | | | | | | |
| <p>4.4.5 Solderability</p> | <ol style="list-style-type: none"> ① No visible mechanical damage. ② Wetting shall exceed 80% coverage. | <ol style="list-style-type: none"> ① Solder temperature: 240±2°C. ② Duration: 3 sec. ③ Solder: Sn/3.0Ag/0.5Cu. ④ Flux: 25% Resin and 75% ethanol in weight. | | | | | | | | |
| <p>4.4.6 Resistance to Soldering Heat</p> | <ol style="list-style-type: none"> ① No visible mechanical damage. ② R25 change: within ±1%. ③ B Constant change: within ±1%. | <ol style="list-style-type: none"> ① Solder temperature: 260±3°C ② Duration: 5 sec. ③ Solder: Sn/3.0Ag/0.5Cu. ④ Flux: 25% Resin and 75% ethanol in weight. ⑤ The chip shall be stabilized at normal condition for 1~2 hours before measuring. | | | | | | | | |

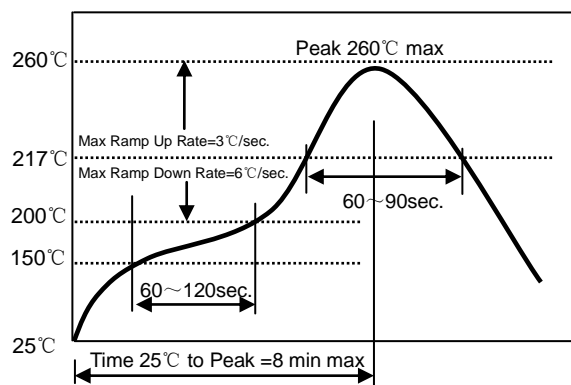
| | | |
|---|---|---|
| <p>4.4.7 Thermal Shock</p> | <p>① No visible mechanical damage. ② R25 change: within $\pm 1\%$. ③ B Constant change: within $\pm 1\%$.</p>  <p>Fig. 4.4.7-1</p> | <p>① Temperature, Time: -55°C for 30 ± 3 min \rightarrow 125°C for 30 ± 3 min. ② Transforming interval: 20sec. Max. ③ Tested cycle: 100 cycles. ④ The chip shall be stabilized at normal condition for 1~2 hours before measuring.</p> |
| <p>4.4.8 Resistance to Low Temperature</p> | <p>① No visible mechanical damage. ② R25 change: within $\pm 1\%$. ③ B Constant change: within $\pm 1\%$.</p> | <p>① Temperature: $-55\pm 2^{\circ}\text{C}$ ② Duration: 1000^{+24} hours. ③ The chip shall be stabilized at normal condition for 1~2 hours before measuring.</p> |
| <p>4.4.9 Resistance to High Temperature</p> | <p>① No visible mechanical damage. ② R25 change: within $\pm 1\%$. ③ B Constant change: within $\pm 1\%$.</p> | <p>① Temperature: $125\pm 2^{\circ}\text{C}$ ② Duration: 1000^{+24} hours. ③ The chip shall be stabilized at normal condition for 1~2 hours before measuring.</p> |
| <p>4.4.10 Damp Heat (Steady States)</p> | <p>① No visible mechanical damage. ② R25 change: within $\pm 1\%$. ③ B Constant change: within $\pm 1\%$.</p> | <p>① Temperature: $60\pm 2^{\circ}\text{C}$ ② Humidity: 90% to 95% RH. ③ Duration: 1000^{+24} hours. ④ The chip shall be stabilized at normal condition for 1~2 hours before measuring.</p> |
| <p>4.4.11 Loading at High Temperature (Life Test)</p> | <p>① No visible mechanical damage. ② R25 change: Within $\pm 1\%$. ③ B constant change: Within $\pm 1\%$.</p> | <p>① Temperature: $85\pm 2^{\circ}\text{C}$ ② Duration: 1000^{+24} hours. ③ Applied current: Max. Permissible Operating Current. ④ The chip shall be stabilized at normal condition for 1~2 hours before measuring.</p> |

5. Recommended Soldering Technologies

5.1 Re-flowing Profile:

- △ Preheat condition: $150 \sim 200^{\circ}\text{C}/60 \sim 120\text{sec}$.
- △ Allowed time above 217°C : $60 \sim 90\text{sec}$.
- △ Max temp: 260°C
- △ Max time at max temp: 10sec.
- △ Solder paste: Sn/3.0Ag/0.5Cu

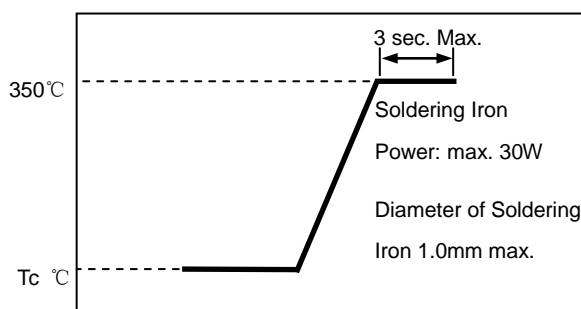
[Note: The reflow profile in the above table is only for qualification and is not meant to specify board assembly profiles. Actual board assembly profiles must be based on the customer's specific board design, solder paste and process, and should not exceed the parameters as the Reflow profile shows.]



5.2 Iron Soldering Profile.

- △ Iron soldering power: Max.30W
- △ Pre-heating: $150^{\circ}\text{C} / 60$ sec.
- △ Soldering Tip temperature: 350°C Max.
- △ Soldering time: 3 sec Max.
- △ Solder paste: Sn/3.0Ag/0.5Cu
- △ Max.1 times for iron soldering

[Note: Take care not to apply the tip of the soldering iron to the terminal electrodes.]



X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for [NTC \(Negative Temperature Coefficient\) Thermistors](#) *category:*

Click to view products by [Yongyutai Electronics](#) *manufacturer:*

Other Similar products are found below :

[118-253FAJ-P01](#) [121-202EAC-P01](#) [135-503LAD-J01](#) [B57250V2473F560](#) [NTCLE410E3103F](#) [199-303KAF-A02](#) [30054-4](#) [M09N038F](#)
[B57423V2473H062](#) [B57471V2474H062](#) [B57620C5223J062](#) [500-52AA04-101](#) [526-31AA19-104](#) [526-31AN12-202](#) [103AT-5-1P-FT](#)
[10K3A542I](#) [11028414-00](#) [111-182CAG-H01](#) [112-103FAF-H01](#) [112-104KBF-F01](#) [526-31AA79-102](#) [B57442V5103J62](#) [B57401V2103H62](#)
[B57621C5472J62](#) [194303KEVA01](#) [B57359V2224J260](#) [B57343V5103J360](#) [50070974-003-01](#) [B57621C5472K062](#) [135-105QAF-J02](#)
[B57421V2153J062](#) [B57230V2103H260](#) [B57471V2684H062](#) [B57471V2333H062](#) [126-153YJC-B01](#) [NTCS0603E3333FHT](#) [121-103FAC-Q02](#)
[144-101FAG-001](#) [526-31AD07-153](#) [GA10K3D232](#) [USUR1000-102G-06](#) [CL109R4120](#) [GA100K6D234](#) [USUR1000-502G-06](#)
[GA10K3MR1I](#) [USUR1000-203G-06](#) [NTCS0603E3333HHT](#) [NTCLE100E3473JB0A](#) [B57863S0303F040](#) [B57871S0103F001](#)